

FORM PTO-1449	SERIAL NO.	CASE NO.
RADEN	09/832,645	9333/267
LIST OF PATENTS AND PUBLICATIONS FOR	FILING DATE	GROUP ART UNIT
APPLICANT'S INFORMATION DISCLOSURE	April 11, 2001	2626
STATEMENT		
(use several sheets if necessary)	APPLICANT(S): Kouichi Satoh	

REFERENCE	DESIGNA	ATION	U.S. PATENT DOC	UMENTS		
EXAMINER		DOCUMENT			CLASS/	FILING
INITIAL		NUMBER	DATE	NAME	SUBCLASS	DATE

FOREIGN PATENT DOCUMENTS

EXAMINER		DOCUMENT			CLASS/	TRANSLATION	
INITIAL		NUMBER	DATE	COUNTRY	SUBCLASS	YES	NO
76	C1	H06-073800	03/15/1994	Japan		Х	
70	C2	H11-219105	08/10/1999	Japan		X	
JW	C3	2000-089776	03/31/2000	Japan		X	
JW	C4	H11-288296	10/19/1999	Japan		Х	
50	C5	H06-243391	09/02/1994	Japan		X	

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	Mil	DATE CONSIDERED	9/12/06

EXAMPNER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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EXAMINER INITIAL DOCUMENT DATE COUNTRY SUBCLASS YES NO

EXAMINER INITIAL		OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)
JW	D1	(Corresponding) Japanese Patent Application No. 2000-114244 Office Action dated July 10, 2006
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EXAMINER ()	DATE CONSIDERED	10	119	106	•

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